

HAC RF E-Field GSM 1900 High

Date: 2020-12-19

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.0°C

Communication System: PCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3

Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)

E Scan – ER3DV6 – 2011: 15 mm from Probe Center to the Device 2

2/Hearing Aid Compatibility Test (101x101x1): Interpolated grid:

dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 12.33 V/m; Power Drift = 0.09 dB

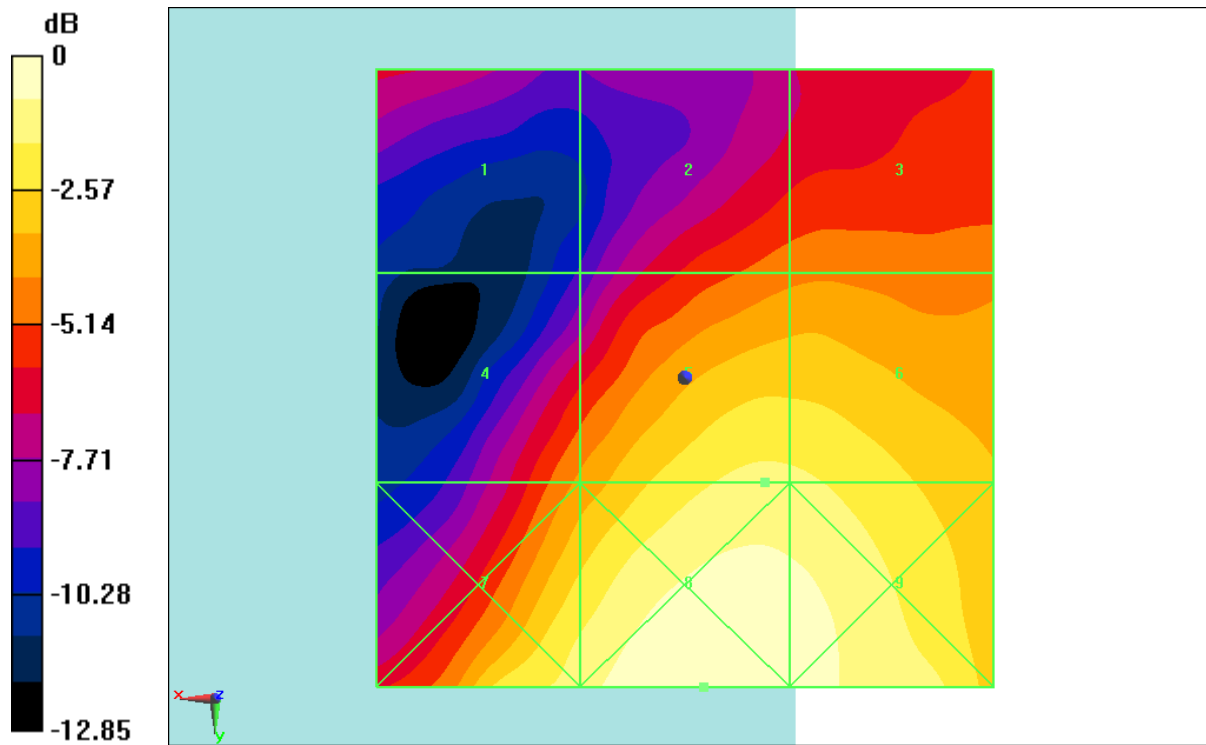
Applied MIF = 3.34 dB

RF audio interference level = 25.85 dBV/m

Emission category: M4

MIF scaled E-field

Grid 1 M4 20.73 dBV/m	Grid 2 M4 22.75 dBV/m	Grid 3 M4 22.9 dBV/m
Grid 4 M4 23.26 dBV/m	Grid 5 M4 25.85 dBV/m	Grid 6 M4 25.78 dBV/m
Grid 7 M4 26.07 dBV/m	Grid 8 M4 27.3 dBV/m	Grid 9 M4 26.95 dBV/m



0 dB = 23.17 V/m = 27.30 dBV/m

Fig B.2 HAC RF E-Field GSM 1900 High

ANNEX C SYSTEM VALIDATION RESULT

E SCAN of Dipole 835 MHz

Date: 2020-12-18

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD835 Dipole =

15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 131.1 V/m; Power Drift = 0.02 dB

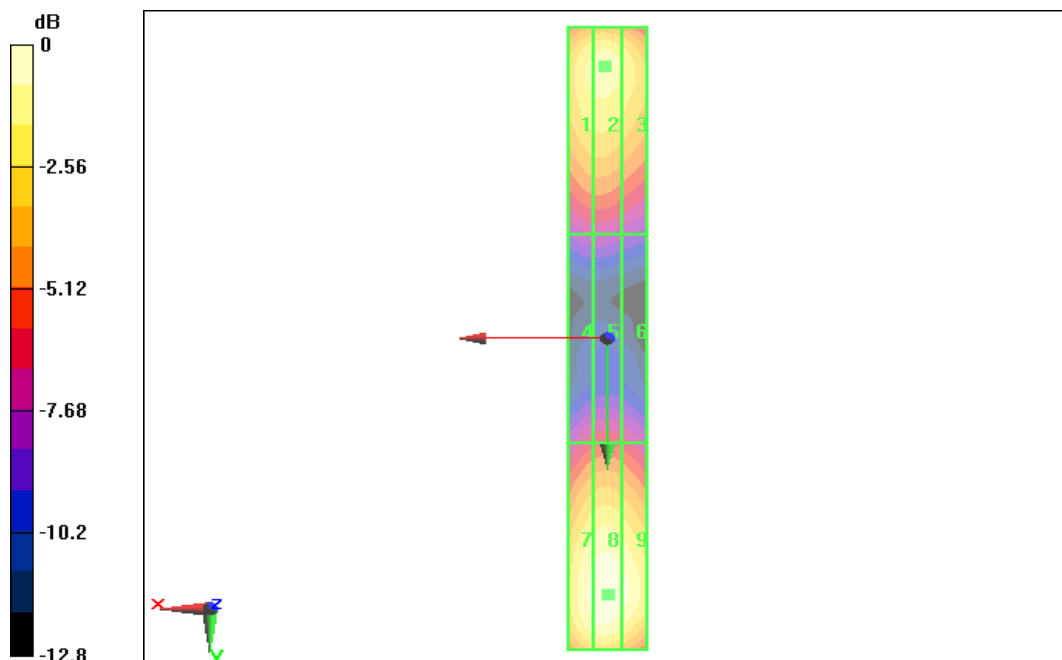
Applied MIF = 0.00 dB

RF audio interference level = 40.58 dBV/m

Emission category: M3

MIF scaled E-field

Grid 1 M3 40.12 dBV/m	Grid 2 M3 40.58 dBV/m	Grid 3 M3 40.71 dBV/m
Grid 4 M4 35.39 dBV/m	Grid 5 M4 35.12 dBV/m	Grid 6 M4 35.11 dBV/m
Grid 7 M3 40.33 dBV/m	Grid 8 M3 40.76 dBV/m	Grid 9 M3 40.64 dBV/m



0 dB = 40.58 dBV/m

E SCAN of Dipole 1880 MHz

Date: 2020-12-19

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: EF3DV3 - SN4060;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 150.1 V/m; Power Drift = 0.02 dB

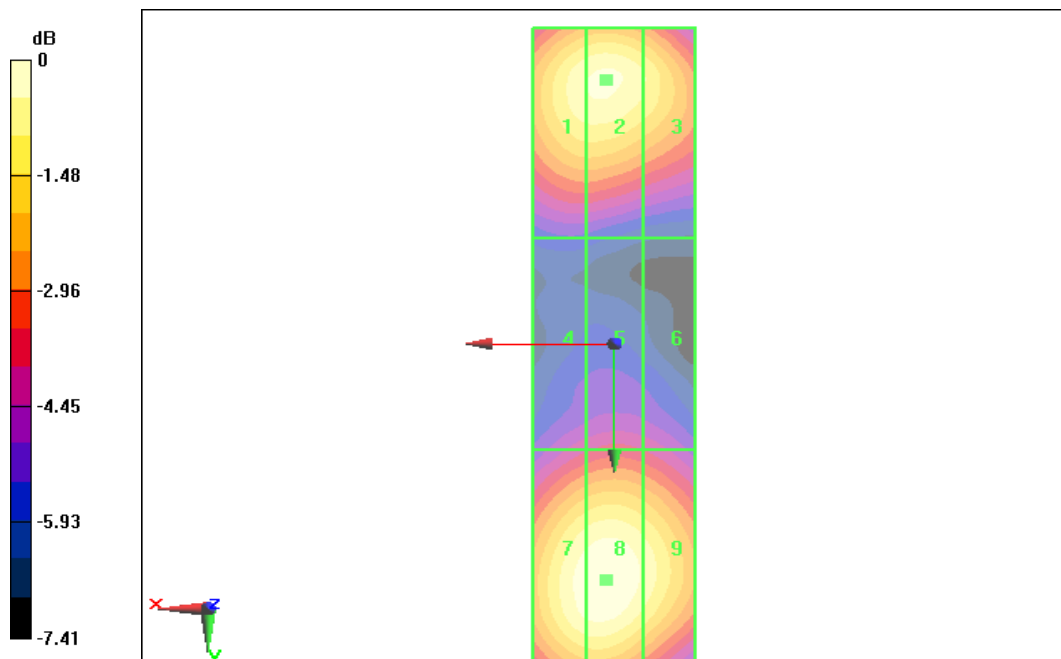
Applied MIF = 0.00 dB

RF audio interference level = 38.93 dBV/m

Emission category: M2

MIF scaled E-field

Grid 1 M2 38.62 dBV/m	Grid 2 M2 38.93 dBV/m	Grid 3 M2 38.98 dBV/m
Grid 4 M2 36.02 dBV/m	Grid 5 M2 36.05 dBV/m	Grid 6 M2 36.13 dBV/m
Grid 7 M2 38.65 dBV/m	Grid 8 M2 38.96 dBV/m	Grid 9 M2 38.95 dBV/m



0 dB = 38.93 dBV/m

ANNEX D PROBE CALIBRATION CERTIFICATE

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **CTTL (Auden)**

Certificate No: **EF3-4060_May20**

CALIBRATION CERTIFICATE

Object **EF3DV3- SN:4060**

Calibration procedure(s) **QA CAL-02.v9, QA CAL-25.v7**
Calibration procedure for E-field probes optimized for close near field
evaluations in air

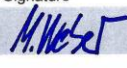
Calibration date: **May 29, 2020**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: CC2552 (20x)	31-Mar-20 (No. 217-03106)	Apr-21
DAE4	SN: 789	27-Dec-19 (No. DAE4-789_Dec19)	Dec-20
Reference Probe ER3DV6	SN: 2328	05-Oct-19 (No. ER3-2328_Oct19)	Oct-20
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-18)	In house check: Jun-20
Network Analyzer E8358A	SN: US41080477	31-Mar-14 (in house check Oct-19)	In house check: Oct-20

	Name	Function	Signature
Calibrated by:	Michael Weber	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	
Issued: June 1, 2020			
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			

Certificate No: EF3-4060_May20

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Calibration Laboratory of
Schmid & Partner
Engineering AG
 Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 0108**

Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
E _n	incident E-field orientation normal to probe axis
E _p	incident E-field orientation parallel to probe axis
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart).
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

EF3DV3 – SN:4060

May 29, 2020

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$)	0.79	0.74	1.28	$\pm 10.1 \%$
DCP (mV) ^B	95.3	97.8	96.5	

Calibration results for Frequency Response (30 MHz – 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.2	77.3	0.1%	77.3	0.1%	$\pm 5.1 \%$
100	77.3	78.2	1.2%	78.5	1.5%	$\pm 5.1 \%$
450	77.1	78.1	1.2%	78.2	1.4%	$\pm 5.1 \%$
600	77.2	77.7	0.6%	77.7	0.7%	$\pm 5.1 \%$
750	77.3	77.4	0.3%	77.4	0.3%	$\pm 5.1 \%$
1800	140.3	138.3	-2.8%	139.2	-2.1%	$\pm 5.1 \%$
2000	133.0	131.4	-2.7%	131.4	-2.7%	$\pm 5.1 \%$
2200	125.1	123.5	-3.3%	124.5	-2.5%	$\pm 5.1 \%$
2500	123.7	122.4	-2.5%	123.2	-1.8%	$\pm 5.1 \%$
3000	78.9	75.8	-4.6%	76.7	-3.4%	$\pm 5.1 \%$
3500	250.5	247.6	-3.3%	243.6	-4.8%	$\pm 5.1 \%$
3700	244.2	239.8	-3.9%	237.6	-4.8%	$\pm 5.1 \%$
5200	50.8	51.3	1.1%	51.7	1.8%	$\pm 5.1 \%$
5500	49.7	49.4	-0.6%	48.2	-3.1%	$\pm 5.1 \%$
5800	48.9	48.6	-0.6%	49.7	1.7%	$\pm 5.1 \%$

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EF3DV3 – SN:4060

May 29, 2020

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu V}$	C	D dB	VR mV	Max dev.	Max Unc ^E (k=2)
0	CW	X	0.00	0.00	1.00	0.00	125.9	$\pm 3.5 \%$	$\pm 4.7 \%$
		Y	0.00	0.00	1.00		166.9		
		Z	0.00	0.00	1.00		128.4		
10352- AAA	Pulse Waveform (200Hz, 10%)	X	2.22	64.12	8.85	10.00	60.0	$\pm 2.9 \%$	$\pm 9.6 \%$
		Y	3.72	69.58	11.72		60.0		
		Z	2.68	66.15	10.03		60.0		
10353- AAA	Pulse Waveform (200Hz, 20%)	X	1.05	61.61	6.69	6.99	80.0	$\pm 1.0 \%$	$\pm 9.6 \%$
		Y	2.73	69.71	10.89		80.0		
		Z	1.39	64.06	8.17		80.0		
10354- AAA	Pulse Waveform (200Hz, 40%)	X	0.64	61.95	5.93	3.98	95.0	$\pm 0.8 \%$	$\pm 9.6 \%$
		Y	20.00	88.10	15.51		95.0		
		Z	1.00	65.44	7.85		95.0		
10355- AAA	Pulse Waveform (200Hz, 60%)	X	0.66	64.74	6.65	2.22	120.0	$\pm 1.0 \%$	$\pm 9.6 \%$
		Y	20.00	93.78	17.20		120.0		
		Z	20.00	84.41	12.55		120.0		
10387- AAA	QPSK Waveform, 1 MHz	X	1.98	70.59	17.17	1.00	150.0	$\pm 1.9 \%$	$\pm 9.6 \%$
		Y	1.94	69.99	16.92		150.0		
		Z	2.02	71.47	17.51		150.0		
10388- AAA	QPSK Waveform, 10 MHz	X	2.54	70.83	17.55	0.00	150.0	$\pm 1.1 \%$	$\pm 9.6 \%$
		Y	2.51	70.47	17.33		150.0		
		Z	2.43	70.41	17.43		150.0		
10396- AAA	64-QAM Waveform, 100 kHz	X	2.34	69.66	19.06	3.01	150.0	$\pm 1.1 \%$	$\pm 9.6 \%$
		Y	2.49	70.33	19.41		150.0		
		Z	2.09	67.16	17.82		150.0		
10399- AAA	64-QAM Waveform, 40 MHz	X	3.51	67.32	16.24	0.00	150.0	$\pm 1.0 \%$	$\pm 9.6 \%$
		Y	3.62	67.78	16.40		150.0		
		Z	3.52	67.45	16.34		150.0		
10414- AAA	WLAN CCDF, 64-QAM, 40MHz	X	4.74	65.60	15.79	0.00	150.0	$\pm 2.0 \%$	$\pm 9.6 \%$
		Y	4.72	65.49	15.68		150.0		
		Z	4.73	65.70	15.88		150.0		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

EF3DV3 – SN:4060

May 29, 2020

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4060

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.20	0.19	4.60
Frequency Corr. (HF)	2.82	2.82	2.82

Sensor Model Parameters

	C1 fF	C2 fF	α V ⁻¹	T1 ms.V ⁻²	T2 ms.V ⁻¹	T3 ms	T4 V ⁻²	T5 V ⁻¹	T6
X	39.4	262.85	37.46	5.11	0.07	4.93	0.89	0.00	1.00
Y	40.3	265.26	36.67	6.10	0.00	4.98	1.07	0.00	1.00
Z	37.4	250.57	37.84	4.63	0.03	4.97	0.00	0.14	1.00

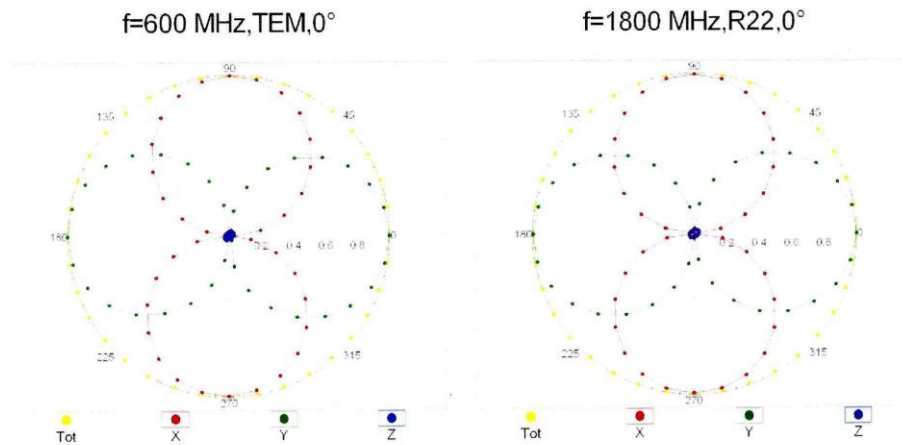
Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-35
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

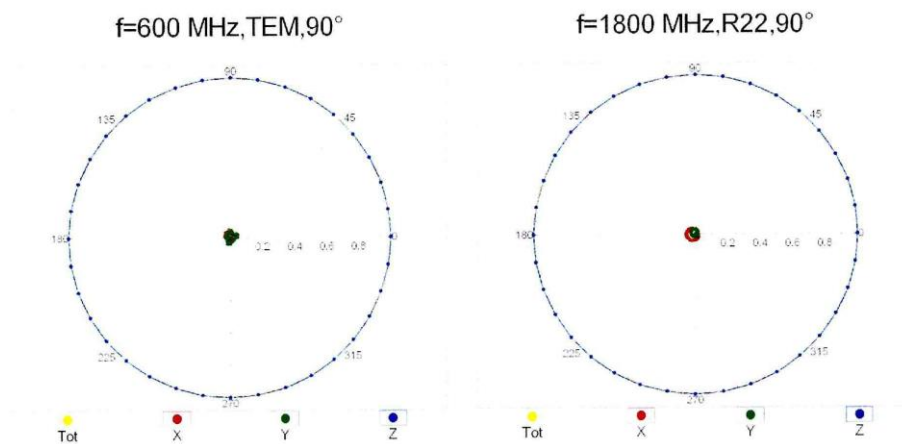
EF3DV3 – SN:4060

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Receiving Pattern (ϕ), $\vartheta = 0^\circ$



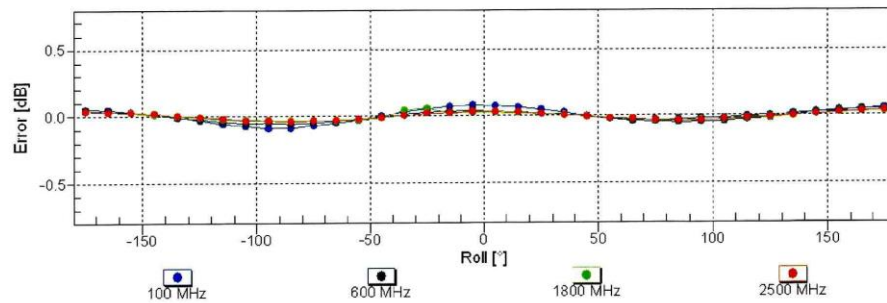
Receiving Pattern (ϕ), $\vartheta = 90^\circ$



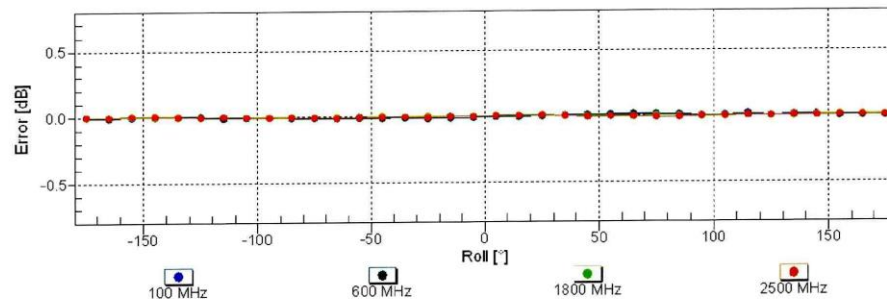
EF3DV3 – SN:4060

May 29, 2020

Receiving Pattern (ϕ), $\vartheta = 0^\circ$


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

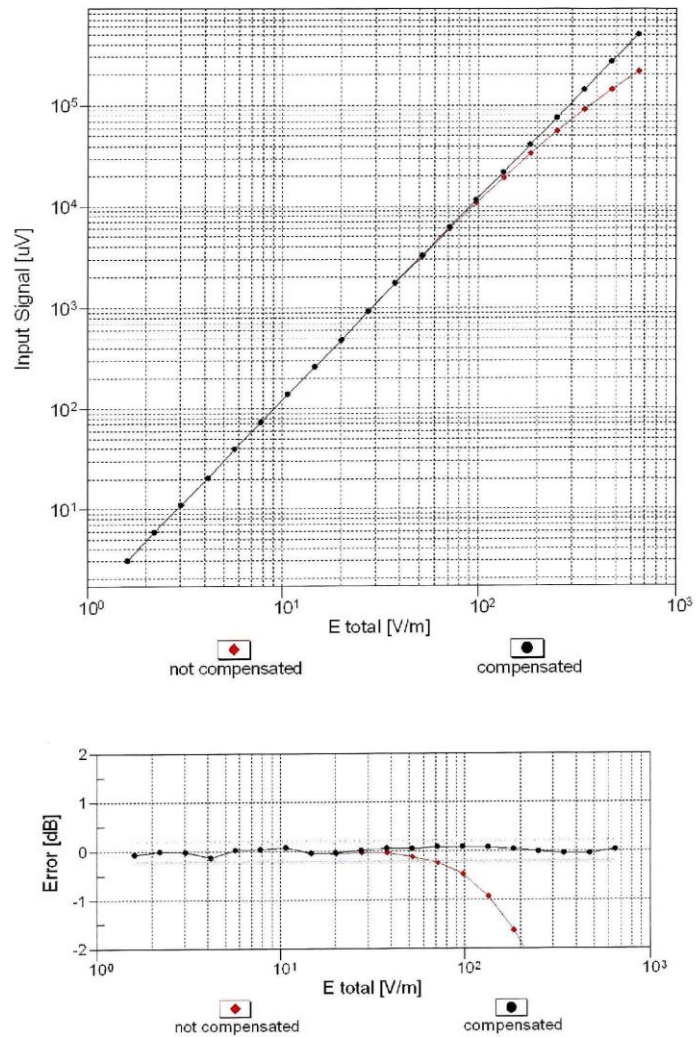
Receiving Pattern (ϕ), $\vartheta = 90^\circ$


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

EF3DV3 – SN:4060

May 29, 2020

Dynamic Range f(E-field) (TEM cell, f = 900 MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)